

International Rectifier

HEXFET® Power MOSFET

- Dynamic dv/dt Rating
- For Automatic Insertion
- End Stackable
- 175°C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Lead-Free

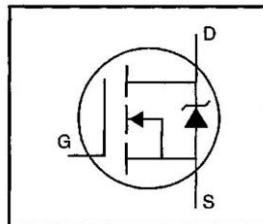
Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

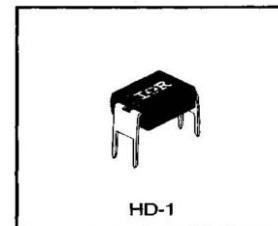
The 4-pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1 inch pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 watt.

PD-95920

IRFD014PbF



$V_{DSS} = 60V$
$R_{DS(on)} = 0.20\Omega$
$I_D = 1.7A$



Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	1.7	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	1.2	
I_{DM}	Pulsed Drain Current ①	14	
$P_D @ T_C = 25^\circ C$	Power Dissipation	1.3	W
	Linear Derating Factor	0.0083	W/°C
V_{GS}	Gate-to-Source Voltage	±20	V
E_{AS}	Single Pulse Avalanche Energy ②	130	mJ
dv/dt	Peak Diode Recovery dv/dt ③	4.5	V/ns
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to +175	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

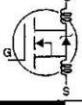
Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
R_{QJA}	Junction-to-Ambient	—	—	120	°C/W

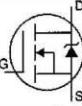
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Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	60	—	—	V	$V_{GS}=0\text{V}$, $I_D=250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.063	—	V°C	Reference to 25°C , $I_D=1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.20	Ω	$V_{GS}=10\text{V}$, $I_D=1.0\text{A}$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$
g_{fs}	Forward Transconductance	0.96	—	—	S	$V_{DS}=25\text{V}$, $I_D=1.0\text{A}$ ④
I_{DSS}	Drain-to-Source Leakage Current	—	—	25	μA	$V_{DS}=60\text{V}$, $V_{GS}=0\text{V}$
		—	—	250		$V_{DS}=48\text{V}$, $V_{GS}=0\text{V}$, $T_J=150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS}=20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS}=-20\text{V}$
Q_g	Total Gate Charge	—	—	11	nC	$I_D=10\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	3.1		$V_{DS}=48\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	5.8		$V_{GS}=10\text{V}$ See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	10	—	ns	$V_{DD}=30\text{V}$
t_r	Rise Time	—	50	—		$I_D=10\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	13	—		$R_G=24\Omega$
t_f	Fall Time	—	19	—		$R_D=2.7\Omega$ See Figure 10 ④
L_D	Internal Drain Inductance	—	4.0	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact
L_s	Internal Source Inductance	—	6.0	—		
C_{iss}	Input Capacitance	—	310	—	pF	$V_{GS}=0\text{V}$
C_{oss}	Output Capacitance	—	160	—		$V_{DS}=25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	37	—		$f=1.0\text{MHz}$ See Figure 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	1.7	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	14		
V_{SD}	Diode Forward Voltage	—	—	1.6	V	$T_J=25^\circ\text{C}$, $I_S=1.7\text{A}$, $V_{GS}=0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	70	140	ns	$T_J=25^\circ\text{C}$, $I_F=10\text{A}$
Q_{rr}	Reverse Recovery Charge	—	0.20	0.40	μC	$dI/dt=100\text{A}/\mu\text{s}$ ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_s+L_D)				

Notes:

① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11) ③ $I_{sd}\leq 10\text{A}$, $dI/dt\leq 90\text{A}/\mu\text{s}$, $V_{DD}\leq V_{(\text{BR})\text{DSS}}$, $T_J\leq 175^\circ\text{C}$

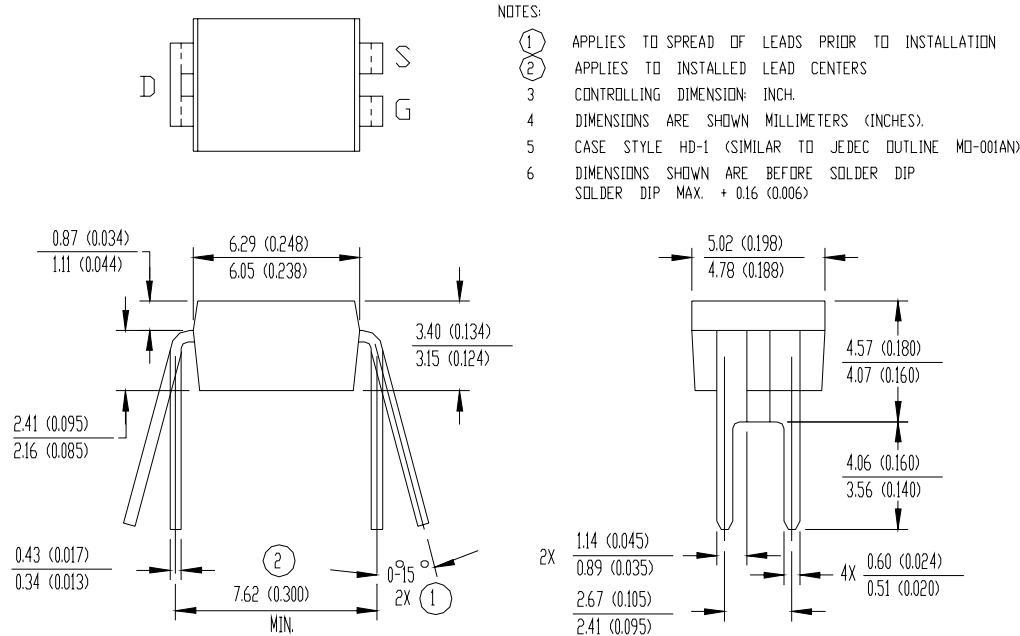
② $V_{DD}=25\text{V}$, starting $T_J=25^\circ\text{C}$, $L=52\text{mH}$ $R_G=25\Omega$, $I_{AS}=1.7\text{A}$ (See Figure 12) ④ Pulse width $\leq 300\ \mu\text{s}$; duty cycle $\leq 2\%$.

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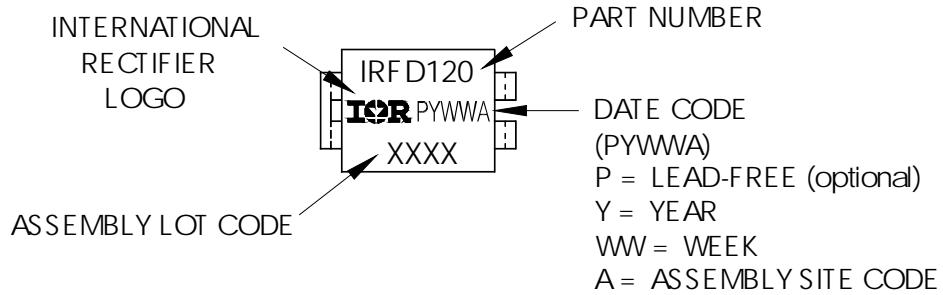
Hexdip Package Outline

Dimensions are shown in millimeters (inches)



Hexdip Part Marking Information

EXAMPLE: THIS IS AN IRFD120



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